

## MOS FIELD EFFECT TRANSISTOR NP84N04CHE, NP84N04DHE, NP84N04EHE

## SWITCHING N-CHANNEL POWER MOS FET

## **DESCRIPTION**

These products are N-channel MOS Field Effect Transistor designed for high current switching applications.

## **FEATURES**

- Channel temperature 175 degree rated
- Super low on-state resistance  $R_{DS(on)} = 5.2 \ m\Omega \ MAX. \ (V_{GS} = 10 \ V, \ I_{D} = 42 \ A)$
- Low Ciss : Ciss = 4410 pF TYP.
- Built-in gate protection diode

## **ORDERING INFORMATION**

PART NUMBER	PACKAGE
NP84N04CHE	TO-220AB
NP84N04DHE	TO-262
NP84N04EHE	TO-263

(TO-220AB)



(TO-262)



(TO-263)

## ABSOLUTE MAXIMUM RATINGS (TA = 25°C)

Voss	40	V
V <sub>GSS</sub>	±20	V
I <sub>D(DC)</sub>	±84	Α
I <sub>D(pulse)</sub>	±336	Α
Рт	200	W
PT	1.8	W
$T_ch$	175	°C
T <sub>stg</sub>	-55 to +175	°C
las	84 / 61 / 22	Α
Eas	70 / 372 / 484	mJ
	VGSS ID(DC) ID(pulse) PT PT Tch Tstg IAS	VGSS         ±20           ID(DC)         ±84           ID(pulse)         ±336           PT         200           PT         1.8           Tch         175           Tstg         -55 to +175           IAS         84 / 61 / 22

**Notes 1.** Calculated constant current according to MAX. allowable channel temperature.

- **2.** PW  $\leq$  10  $\mu$ s, Duty cycle  $\leq$  1%
- 3. Starting T<sub>ch</sub> = 25°C, V<sub>DD</sub> = 20 V, R<sub>G</sub> = 25  $\Omega$ , V<sub>GS</sub> = 20  $\rightarrow$  0 V (see Figure 4.)

## THERMAL RESISTANCE

Channel to Case	Rth(ch-C)	0.75	°C/W
Channel to Ambient	Rth(ch-A)	83.3	°C/W

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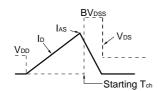


## **ELECTRICAL CHARACTERISTICS (TA = 25°C)**

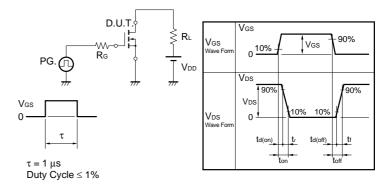
CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Zero Gate Voltage Drain Current	IDSS	VDS = 40 V, VGS = 0 V			10	μΑ
Gate Leakage Current	Igss	V <sub>GS</sub> = ±20 V, V <sub>DS</sub> = 0 V			±10	μΑ
Gate to Source Threshold Voltage	VGS(th)	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 250 μA	2.0	3.0	4.0	>
Forward Transfer Admittance	<b>y</b> fs	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 42 A	20	47		S
Drain to Source On-state Resistance	RDS(on)	VGS = 10 V, ID = 42 A		4.6	5.2	mΩ
Input Capacitance	Ciss	V <sub>DS</sub> = 25 V		4410	6620	pF
Output Capacitance	Coss	Ves = 0 V		950	1430	pF
Reverse Transfer Capacitance	Crss	f = 1 MHz		490	890	pF
Turn-on Delay Time	<b>t</b> d(on)	VDD = 20 V, ID = 42 A		36	79	ns
Rise Time	<b>t</b> r	V <sub>GS</sub> = 10 V		25	62	ns
Turn-off Delay Time	<b>t</b> d(off)	$R_G = 1 \Omega$		77	150	ns
Fall Time	<b>t</b> f			28	69	ns
Total Gate Charge	QG	VDD = 32 V		87	130	nC
Gate to Source Charge	Qgs	V <sub>GS</sub> = 10 V		20		nC
Gate to Drain Charge	QGD	I <sub>D</sub> = 84 A		32		nC
Body Diode Forward Voltage	V <sub>F(S-D)</sub>	I <sub>F</sub> = 84 A, V <sub>GS</sub> = 0 V		1.0		V
Reverse Recovery Time	trr	I <sub>F</sub> = 84 A, V <sub>GS</sub> = 0 V		49		ns
Reverse Recovery Charge	Qrr	di/dt = 100 A/μs		60		nC

## **TEST CIRCUIT 1 AVALANCHE CAPABILITY**

# $\begin{array}{c} \text{D.U.T.} \\ \text{Rg} = 25 \Omega \\ \text{VGS} = 20 \rightarrow 0 \text{ V} \\ \end{array}$



## **TEST CIRCUIT 2 SWITCHING TIME**



## TEST CIRCUIT 3 GATE CHARGE

0 25 50

## TYPICAL CHARACTERISTICS (TA = 25°C)

Figure 1. DERATING FACTOR OF FORWARD BIAS SAFE OPERATING AREA

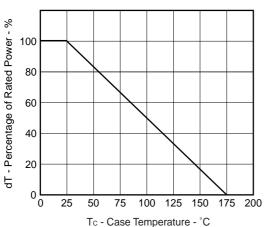


Figure 3. FORWARD BIAS SAFE OPERATING AREA

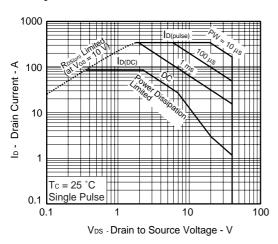


Figure2. TOTAL POWER DISSIPATION vs.
CASE TEMPERATURE

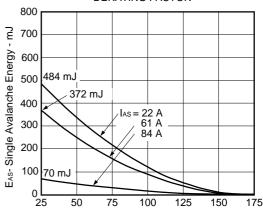
280
240
200
200
120
80
120
40

75 100 125

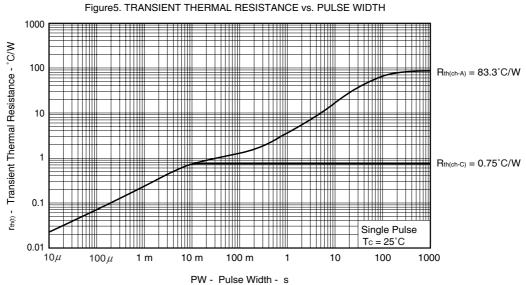
Figure4. SINGLE AVALANCHE ENERGY DERATING FACTOR

 $\mbox{Tc}$  -  $\mbox{Case}$  Temperature  $\mbox{ - }\mbox{ }\m$ 

150 175



Starting Tch - Starting Channel Temperature - °C



Data Sheet D14240EJ5V0DS 3

Figure 6. FORWARD TRANSFER CHARACTERISTICS

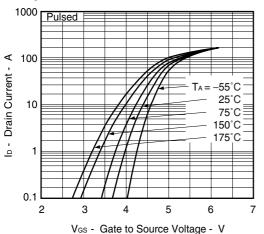


Figure 8. FORWARD TRANSFER ADMITTANCE vs. DRAIN CURRENT

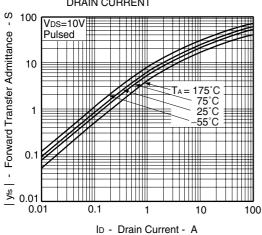


Figure 10. DRAIN TO SOURCE ON-STATE R<sub>DS(on)</sub> - Drain to Source On-state Resistance - mΩ RESISTANCE vs. DRAIN CURRENT Pulsed 15 10 V<sub>GS</sub> = 10 V 5 10 100 1000

ID - Drain Current - A

Figure 7. DRAIN CURRENT vs. DRAIN TO SOURCE VOLTAGE

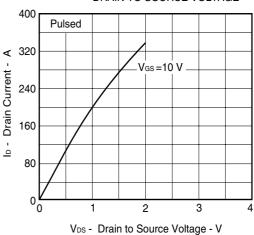


Figure9. DRAIN TO SOURCE ON-STATE RESISTANCE vs. GATE TO SOURCE VOLTAGE

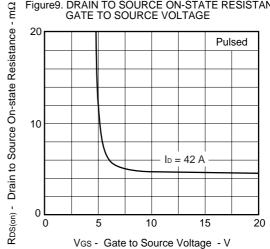
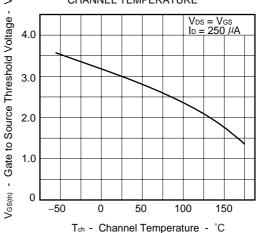
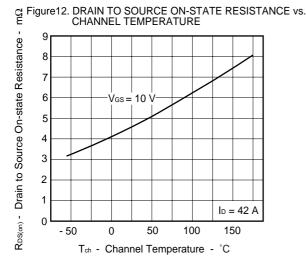
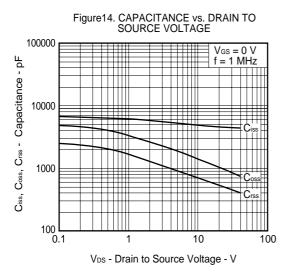
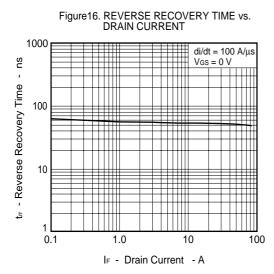


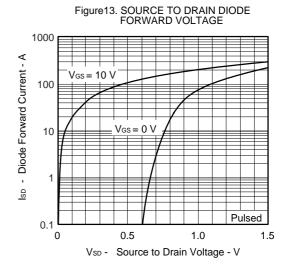
Figure 11. GATE TO SOURCE THRESHOLD VOLTAGE vs. CHANNEL TEMPERATURE

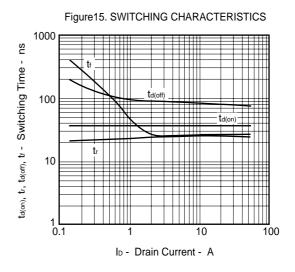


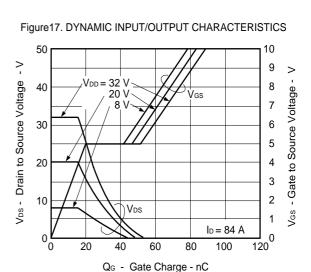






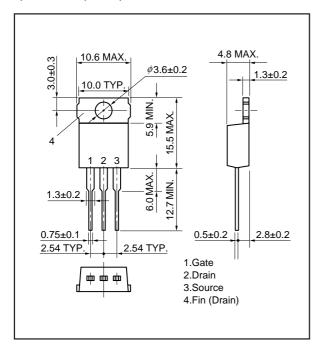




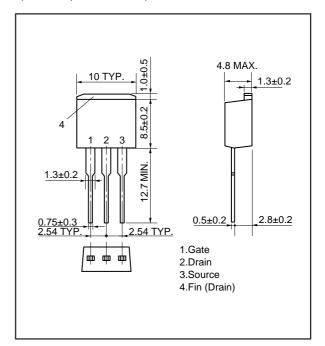


## PACKAGE DRAWINGS (Unit: mm)

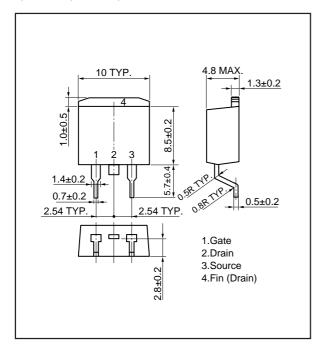
## 1) TO-220AB (MP-25)



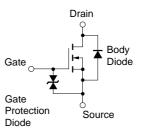
## 2) TO-262 (MP-25 Fin Cut)



## 3) TO-263 (MP-25ZJ)



## **EQUIVALENT CIRCUIT**



**Remark** The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

[MEMO]

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